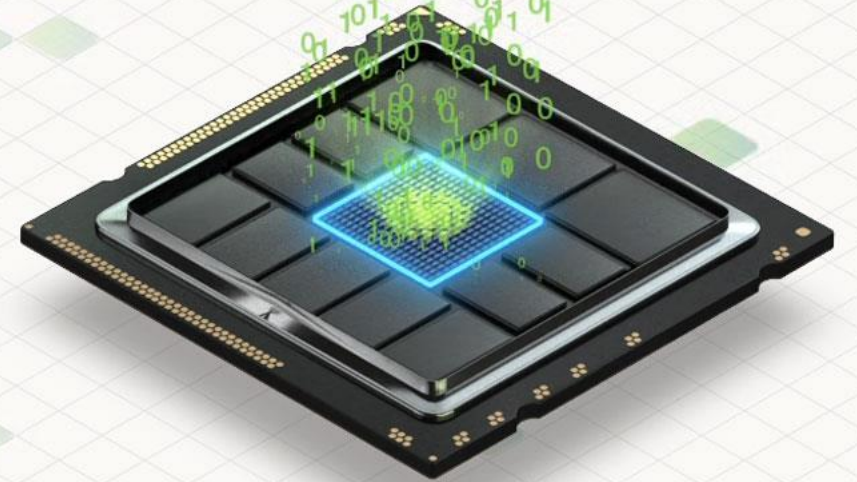


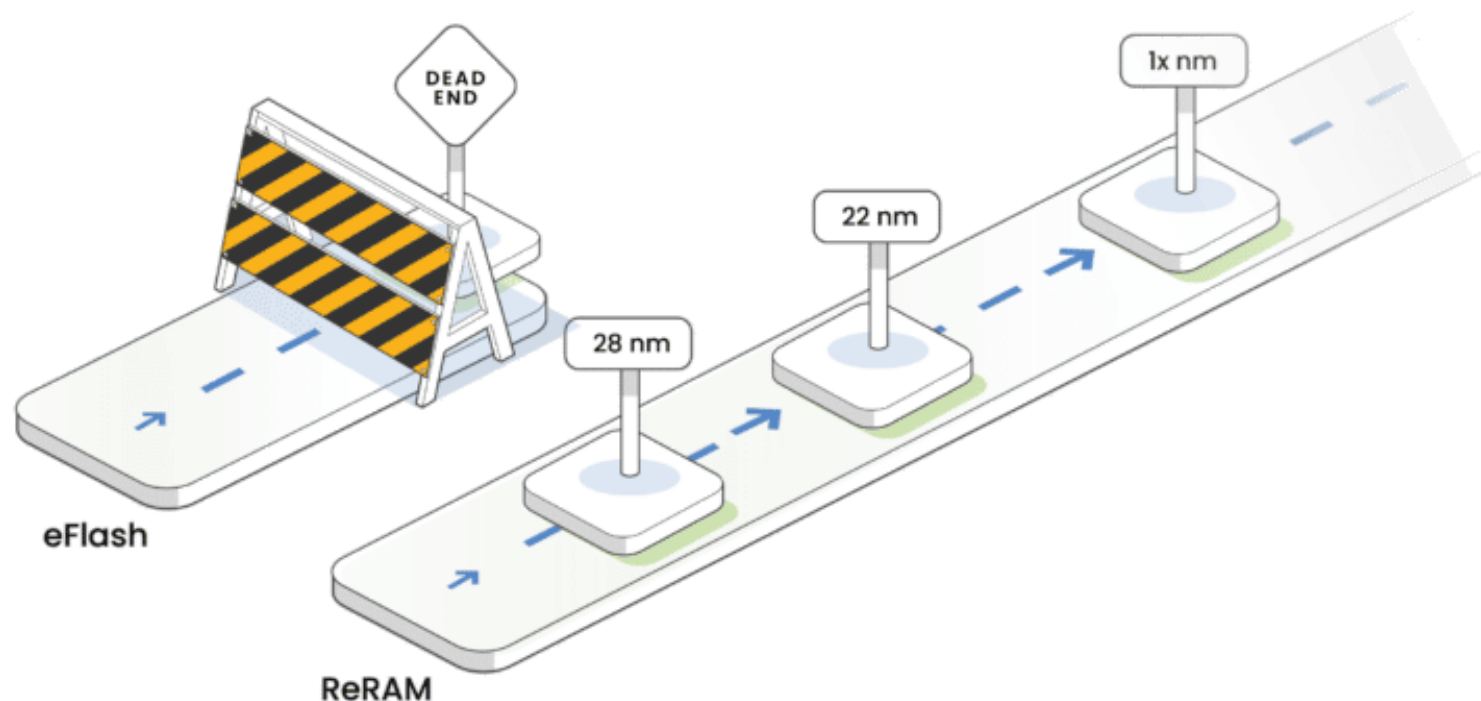
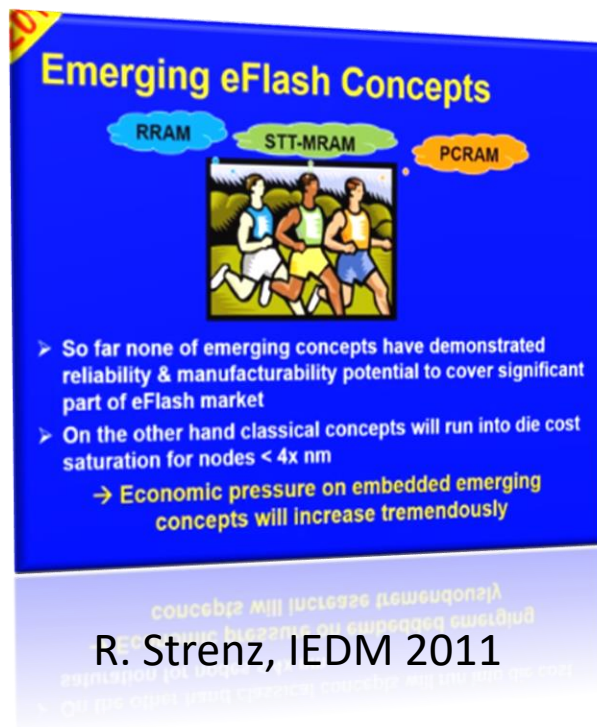
ReRAM Gets Real: From Concept to Market

MPSoC 2025

Gabriel Molas

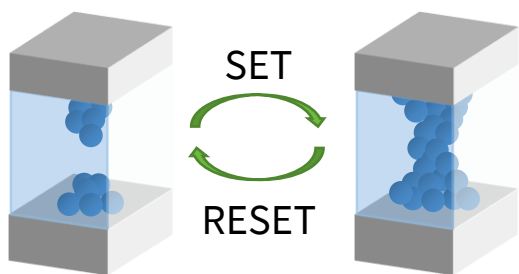


Emerging NVM for MCU



- ❖ Flash stuck at 28-22nm because of integration cost and complexity increase
- ❖ **Emerging NVM** (ReRAM, PCM, MRAM) went through long R&D and are now replacing Flash for embedded applications
 - ◆ The market expected to significantly grow in the next years

ReRAM History



1960

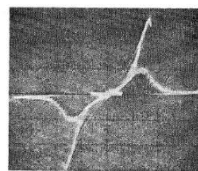
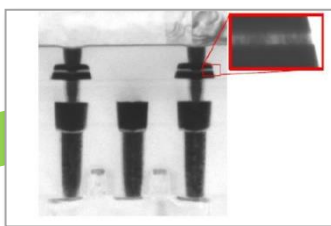


Fig. 1—Current-voltage locus, 60 cps. Ordinate scale is 40 ma/div, abscissa 2v/div. Superimposed is the high initial resistance locus resulting from sudden voltage removal at about 7-volts peak. The upper negative resistance curve is for voltage increasing, the lower for voltage decreasing.

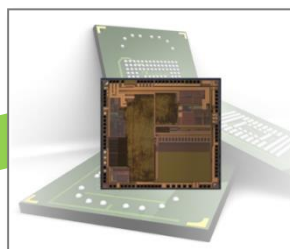
Resistive switching
phenomena in
oxides

2000s



Samsung
RRAM integrated in
0,18 μ m...
40 years later

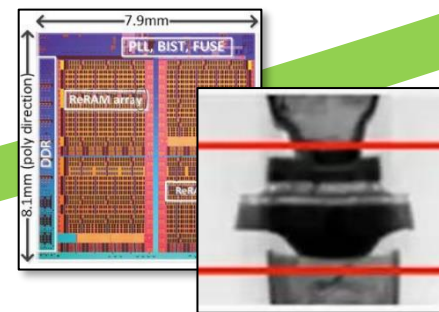
2010s



Panasonic
1st commercially available
implementation of RRAM

Healthcare, security equipment
or sensor processing applications

2019



22nm FinFET
Intel, TSMC
10⁴ cycles, 85°C 10ys
retention

2022-2024

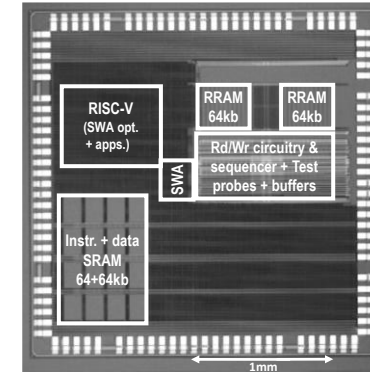


Infineon & TSMC
(Automotive μ C
28nm)

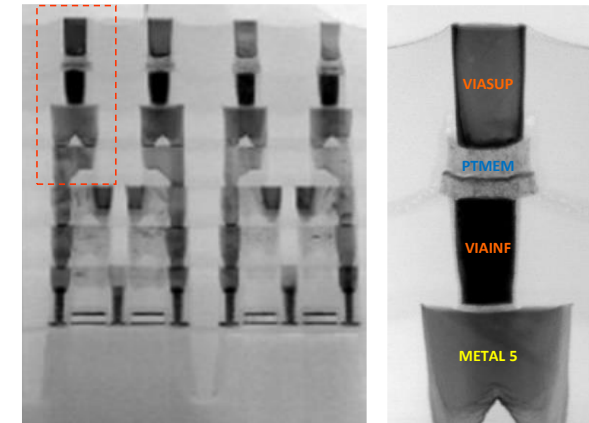
ReRAM products available for embedded applications...
50 years after the switching effect was discovered

Weebit ReRAM

- ❖ Weebit has collaborated with CEA-Leti since 2016 to develop its ReRAM
 - ◆ Memory module fully functional and **qualified** for 150°C, 100K cycles
 - ◆ Mbit arrays demonstrated at **28nm**
 - ◆ Taped-out 8Mb prototype in **22nm FD-SOI**
- ❖ On the path towards mass production
 - ◆ Weebit ReRAM IP available for production in SkyWater PDK for customers
 - ◆ Testing 1Mb ReRAM module in DB HiTek's 130nm BCD process
 - ◆ Licensed ReRAM to onsemi, 65nm BCD process for automotive
- ❖ **R&D** continuously ongoing to improve technology and scale ReRAM technology to smaller nodes



130nm ST/Leti MODULE



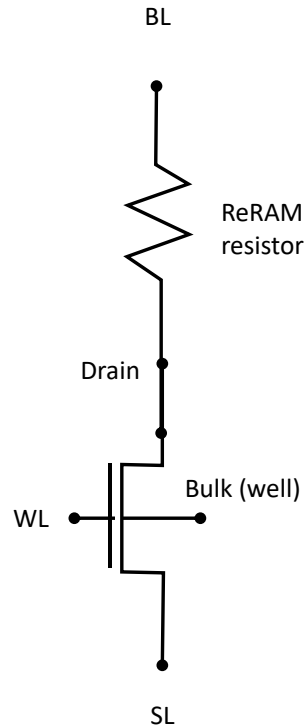
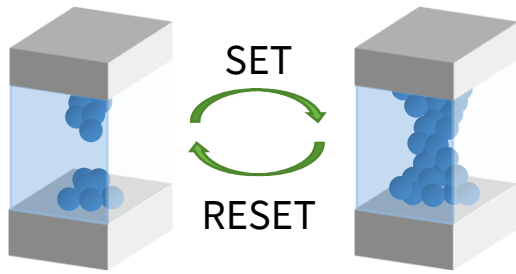
ReRAM in 28nm

Outline

- ❖ Context and introduction
- ❖ Technology challenges and solutions
 - ◆ Bit error rate
 - ◆ Stability
- ❖ AI opportunities
- ❖ Conclusions



ReRAM Basics



❖ Operating principle

- ◆ Formation/disruption of a conductive filament in a resistive layer (metal oxide) – 10nm scalability demonstrated today (1D filament)

❖ 2-mask adder

- ◆ Very few added steps compared to other NVM technologies
- ◆ Lower wafer cost than competing NVM technologies

❖ Fab-friendly materials

- ◆ No contamination risk, No special handling, etc.

❖ Using existing deposition techniques and tools

- ◆ Easy to integrate into any CMOS fab

❖ BEOL technology

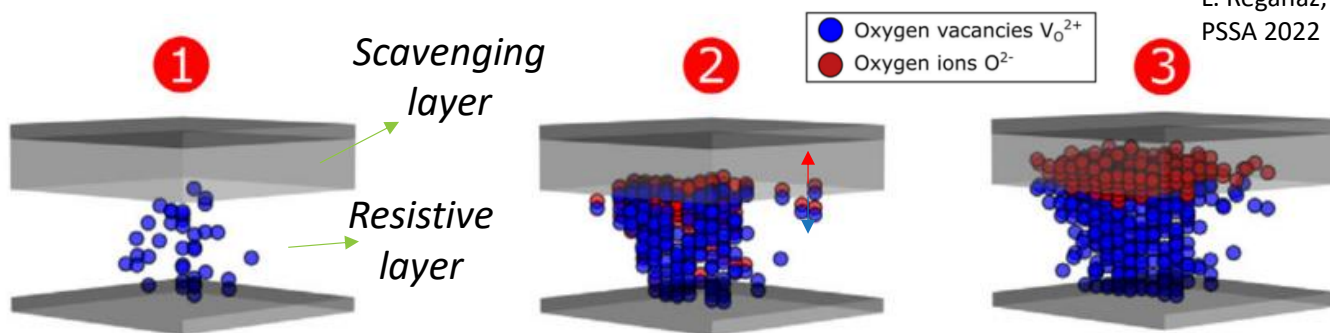
- ◆ Stack between any 2 metal layers
- ◆ No interference with FEOL – Easier to embed with existing Analog / RF circuits
- ◆ Easy to scale from one process variation to another

❖ MCU/IoT: a natural fit for ReRAM

- ◆ Lower Power Consumption, Minimized Cost, High-level of Integration, good retention and endurance

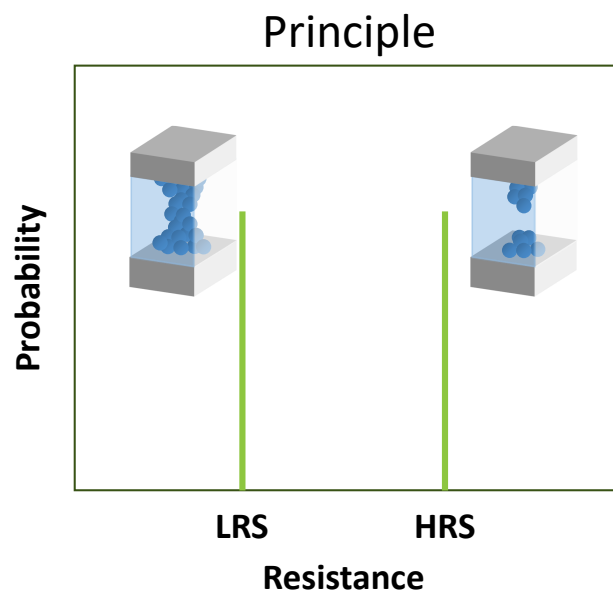
Basics of ReRAM Switching Physics

L. Reganaz,
PSSA 2022



- ❖ Generation and diffusion of VO_2^+/O_2^- pairs in resistive layer
- ❖ Oxygen ions absorbed in the scavenging layer (Top electrode acts as an oxygen reservoir)
- ❖ Conductive filament formed in the resistive layer when sufficient voltage is applied

- ❖ Stochastic character of filament formation and dissolution
- ❖ ReRAM resistance is spread for HRS and LRS



Diffusion

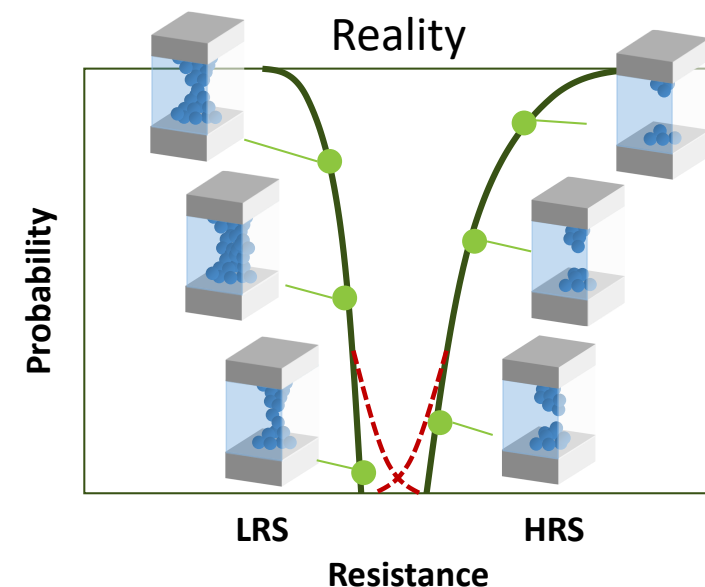
$$\Gamma_D(x, y, z) = \nu_0 \exp\left(-\frac{E_{A,D} - \frac{1}{2}Qd(1 + L_X)E}{k_B T(x, y, z)}\right)$$

Recombination

$$\Gamma_R(x, y, z) = \nu_0 \exp\left(-\frac{E_{A,R}}{k_B T(x, y, z)}\right)$$

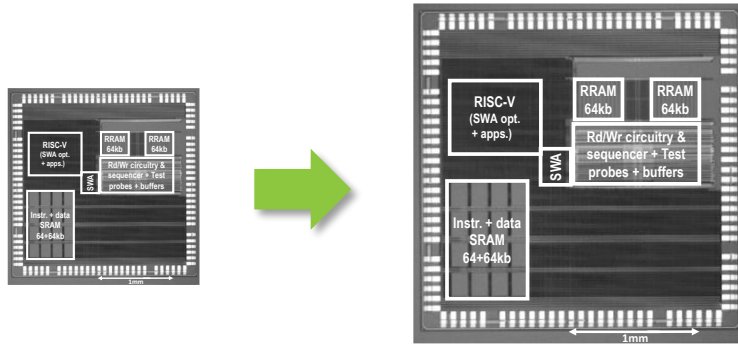
Generation

$$\Gamma_G(x, y, z) = \nu_0 \exp\left(-\frac{E_{A,G} - bE(x, y, z)}{k_B T(x, y, z)}\right)$$



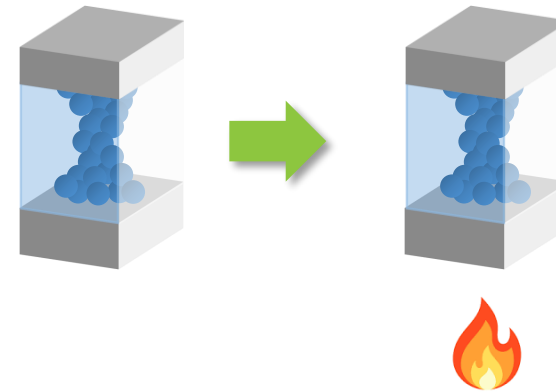
| Technology Enhancements

- ❖ 2 important examples (among others...)



Margin / Error rate

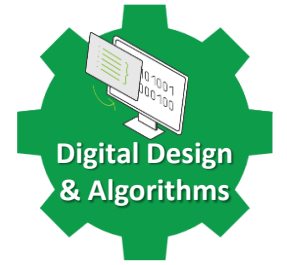
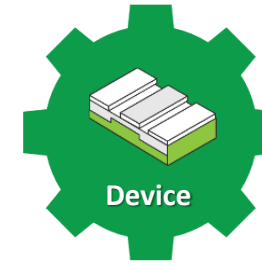
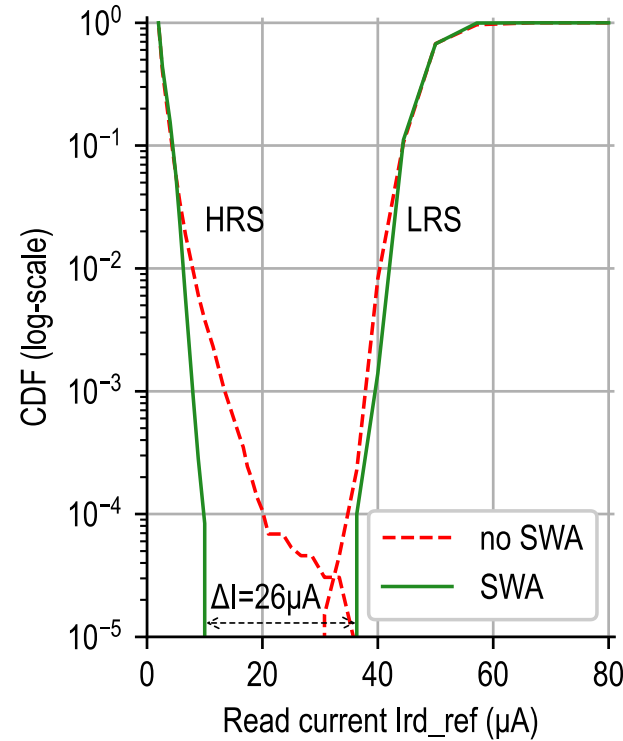
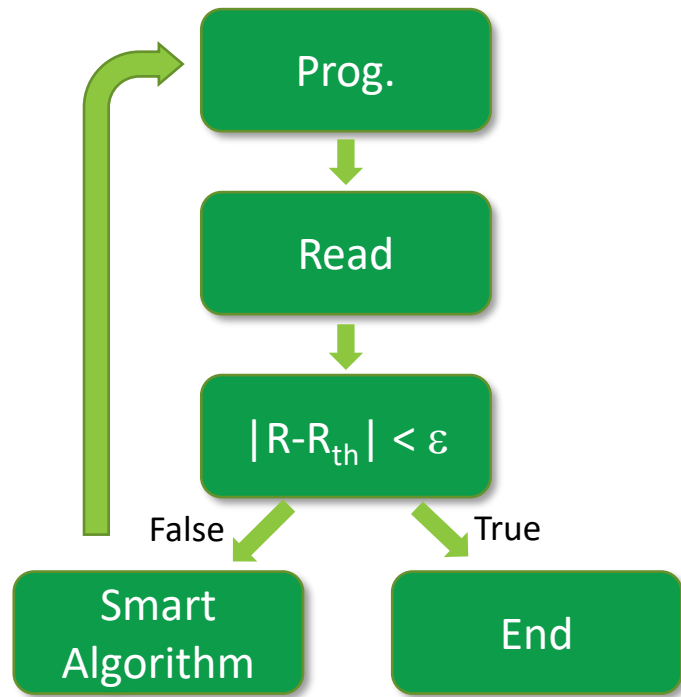
Lower error rate required as memory
capacity increases



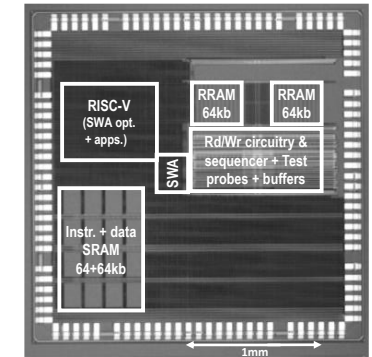
Stability

High ReRAM stability required for high
temp demanding applications
(automotive...)

Algorithms for Margin Increase



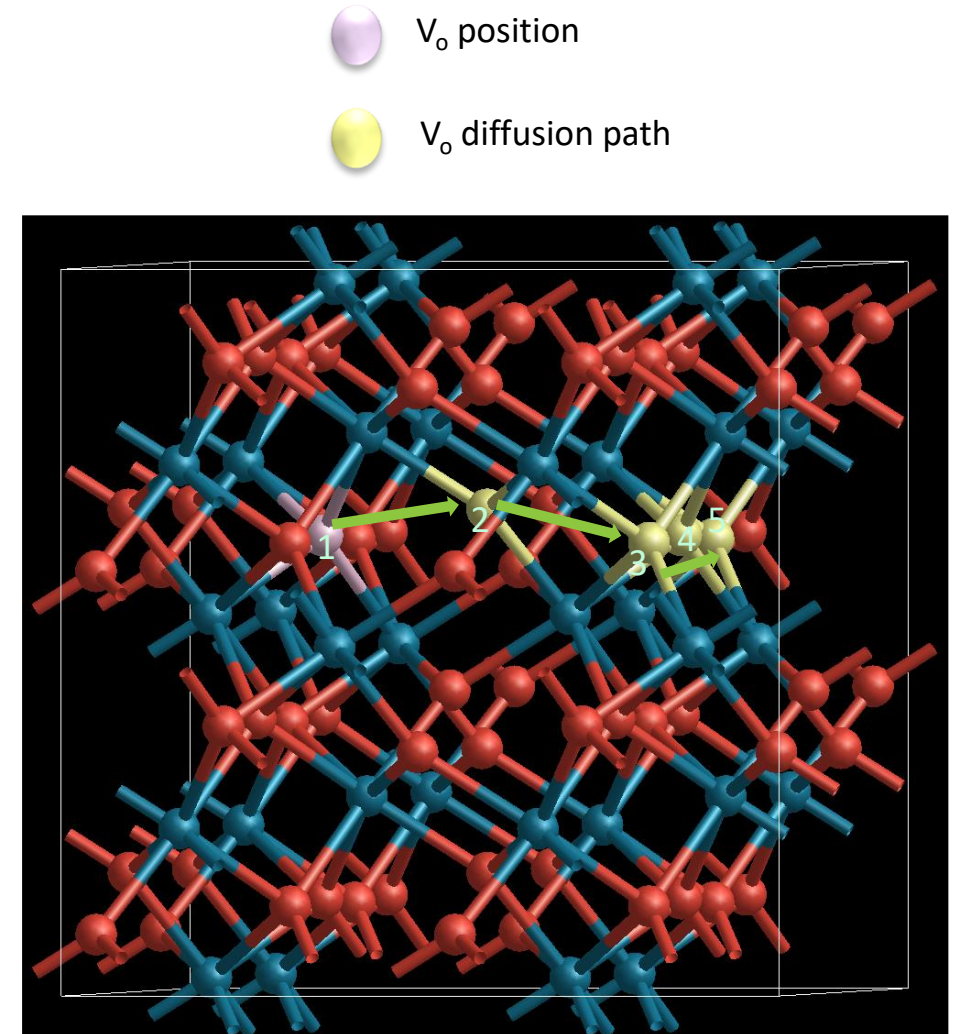
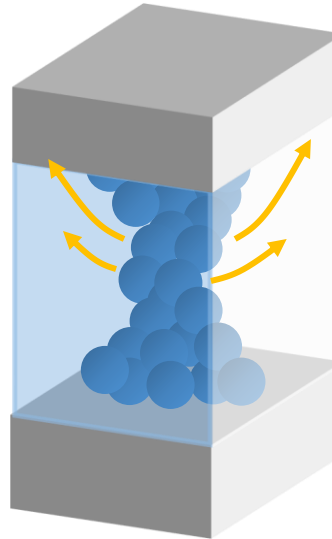
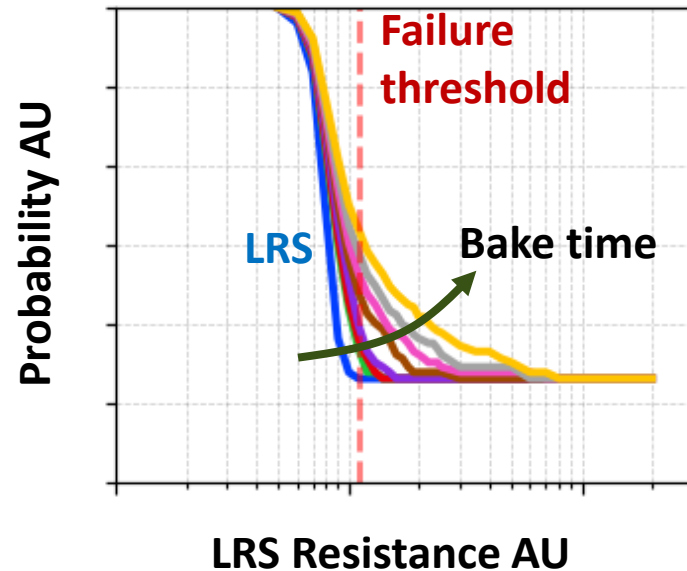
B. Giraud, IMW 2023
List, Leti – Weebit



- ❖ **Program algorithms:** resistance is read after programming, and ReRAM is programmed again if needed
- ❖ → Larger margin is achieved

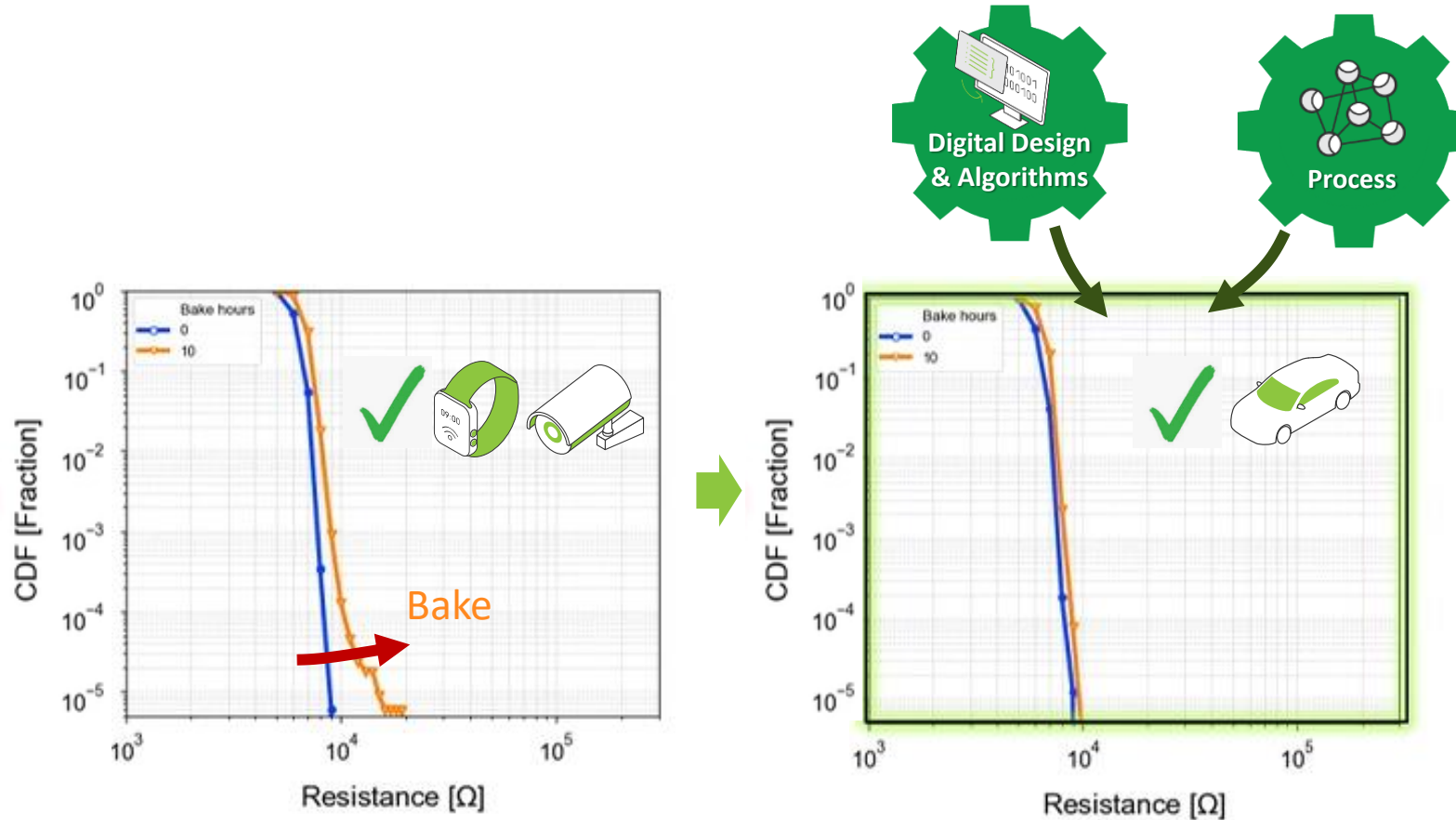
Basics of ReRAM Retention Degradation

Low Resistance State Retention responsible for data loss



- ❖ Some cells undersee V_O migration during high Temp. bake
- ❖ → Progressive resistance distribution spread, leading to information data loss

Retention Improvement

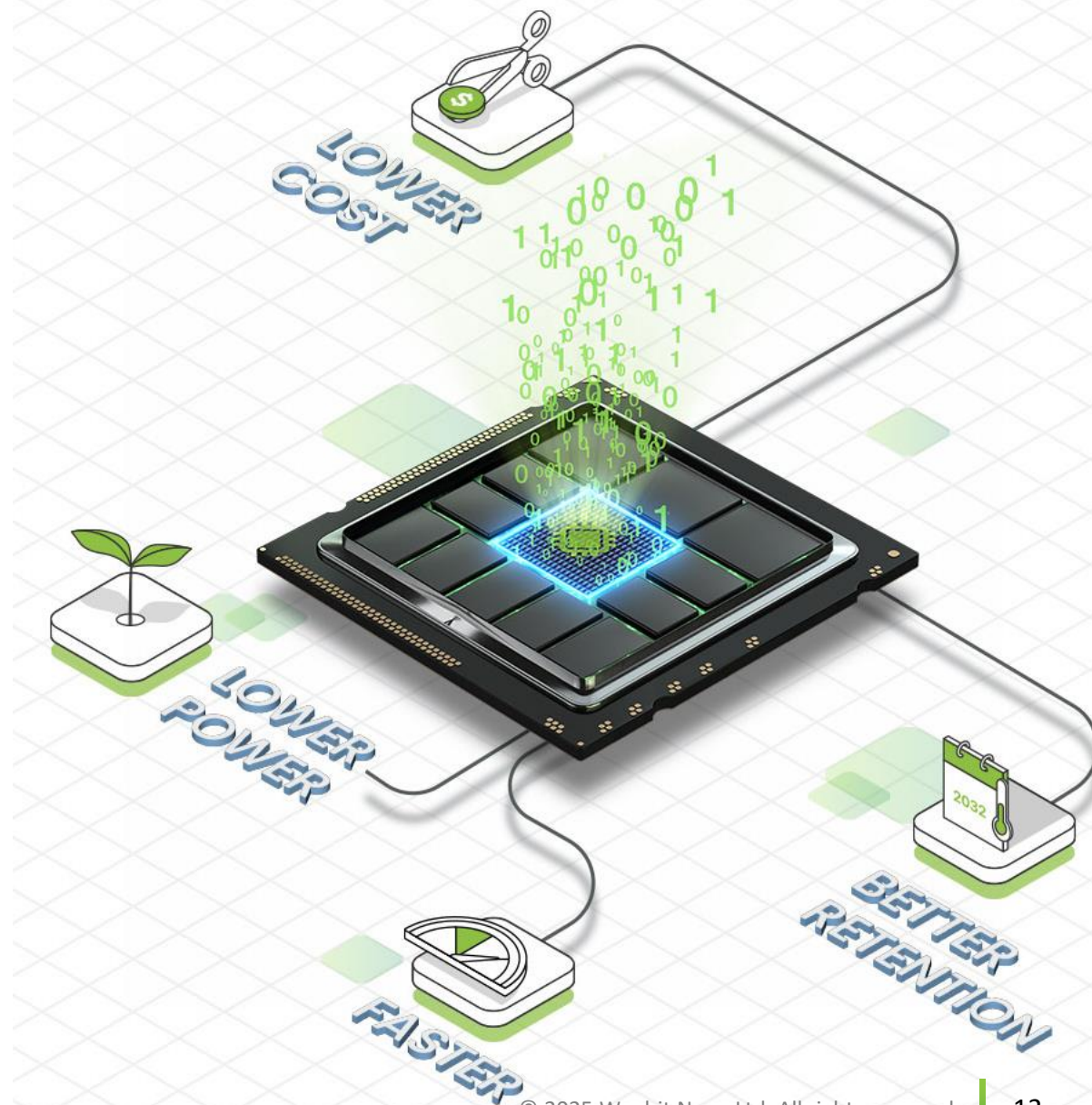


- ❖ Improved retention
 - ◆ Part can be due to **more stable material** (lower oxygen migration energy)
 - ◆ Part can be due to **improved programming algorithm**, leading to more stable filament

- ❖ Stack optimization and new programming algorithm development for more stable ReRAM and higher temperature applications

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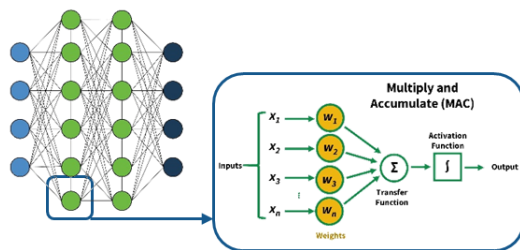


ReRAM for Neuromorphic

ReRAM perfectly fits in brain inspired systems, in a timely manner:

Embedded, Edge AI

Short Term



ReRAM used as eNVM to store synaptic weights of the NN

Mid Term

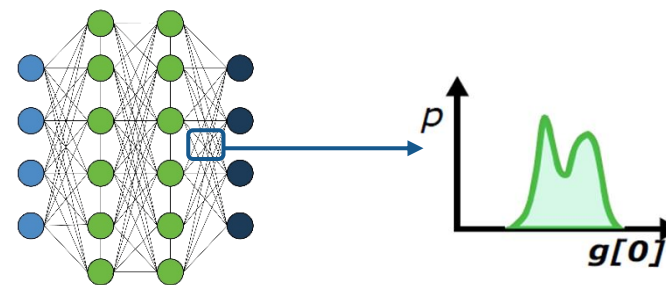
In-Memory Compute:
AI and ML



Computing is done within the ReRAM itself

New Concepts

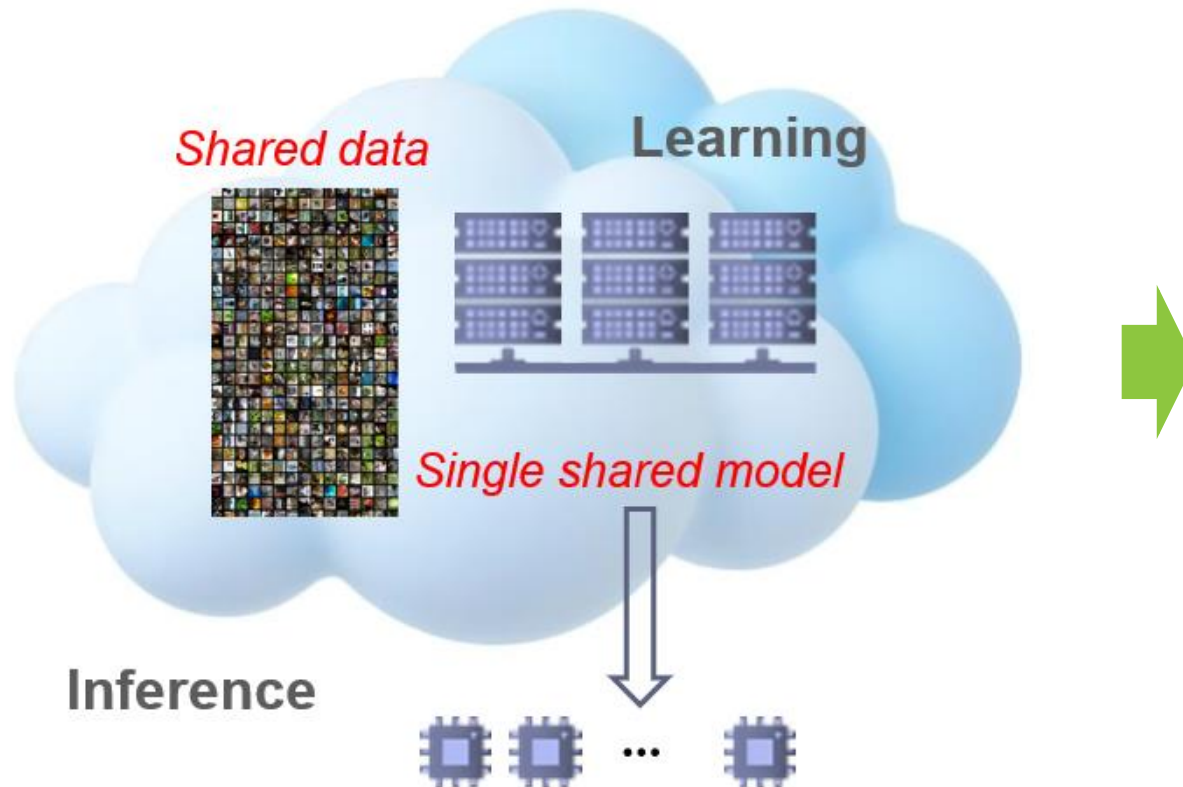
Longer Term



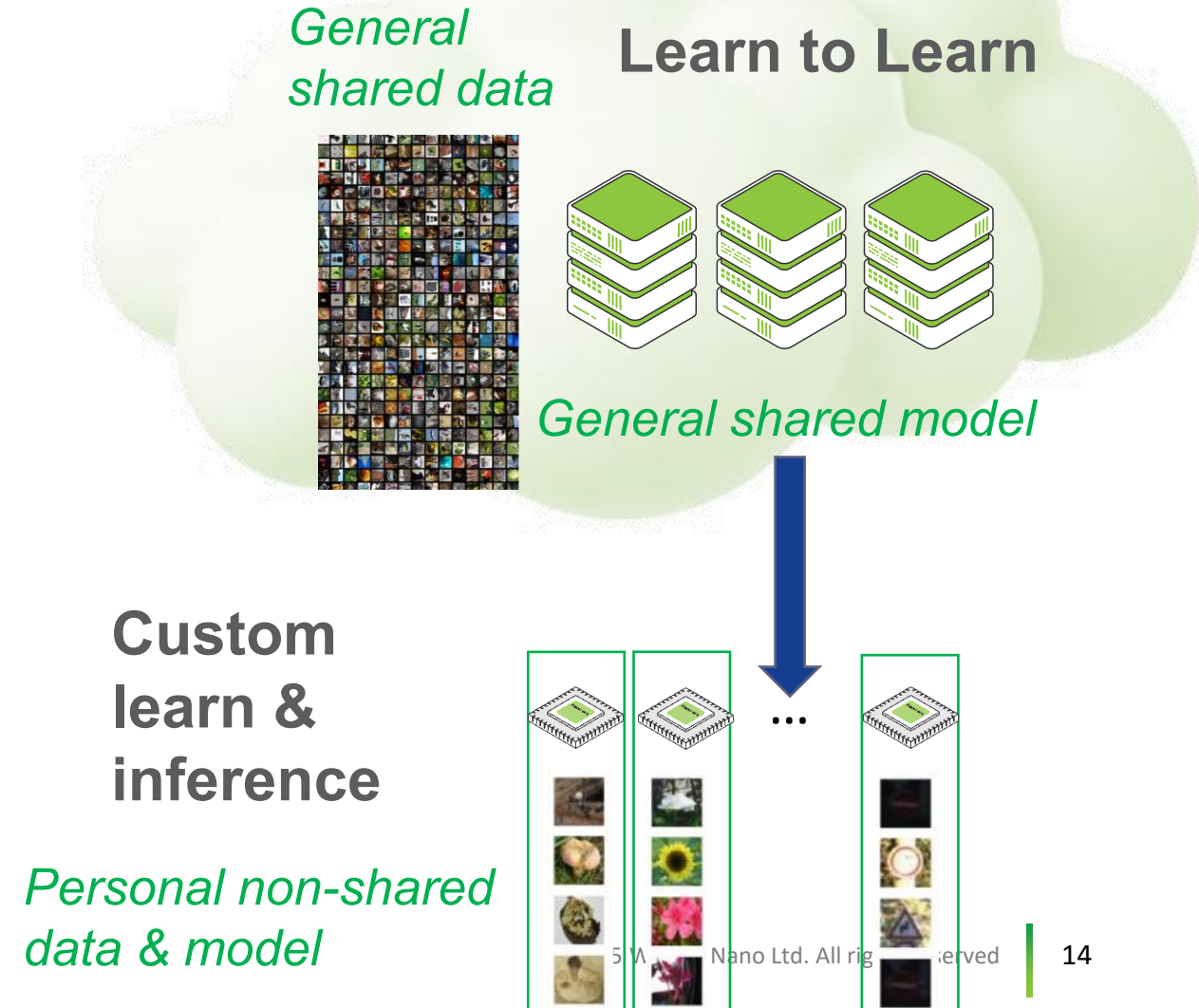
New concepts take advantage of ReRAM specificities

| Distributed Learning for Secure AI

Today: Training in the Cloud, Inference at the Edge



Tomorrow: Distributed Learning for Secure AI

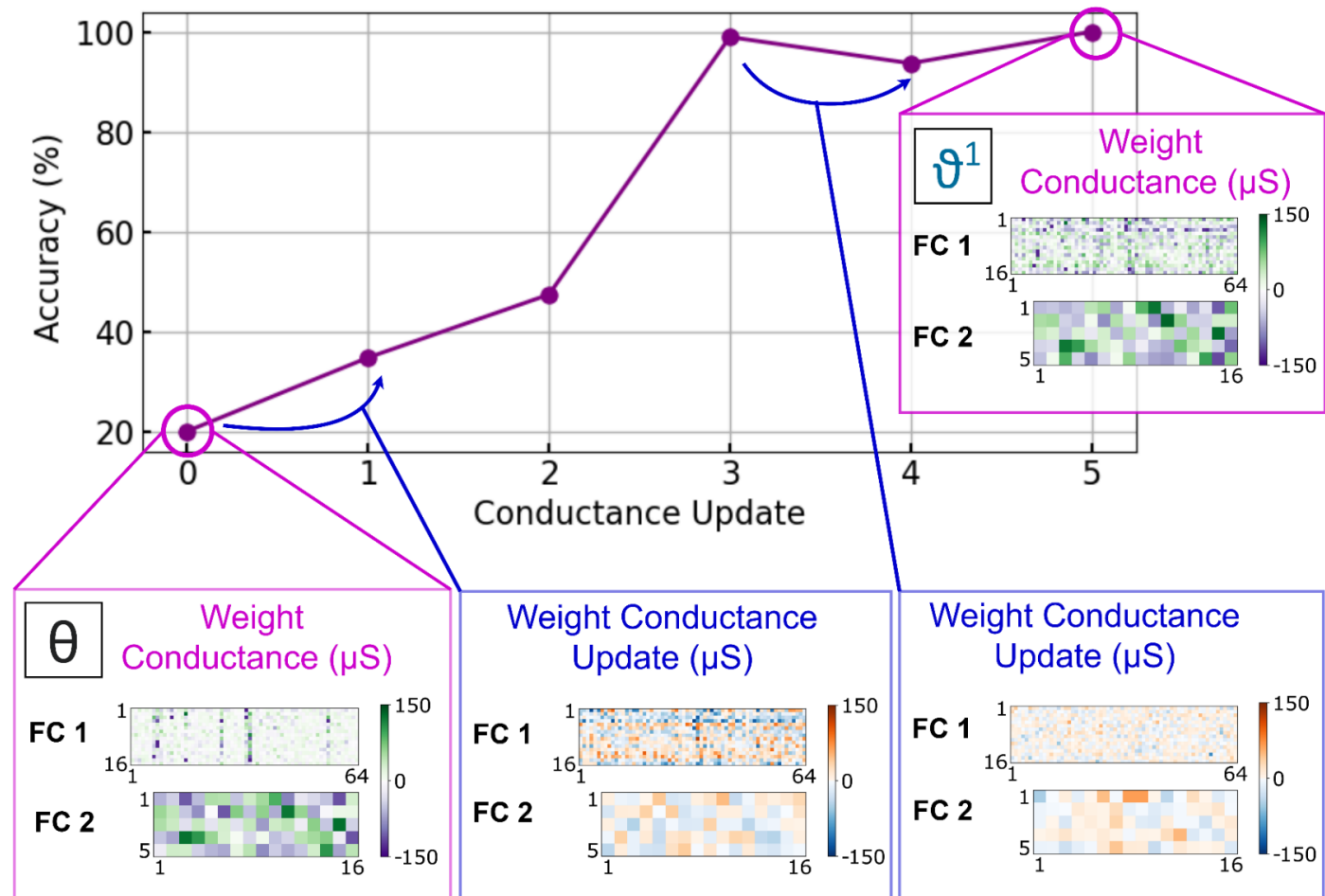


Distributed Learning for Secure AI

Model-Agnostic-Meta-Learning (MAML)

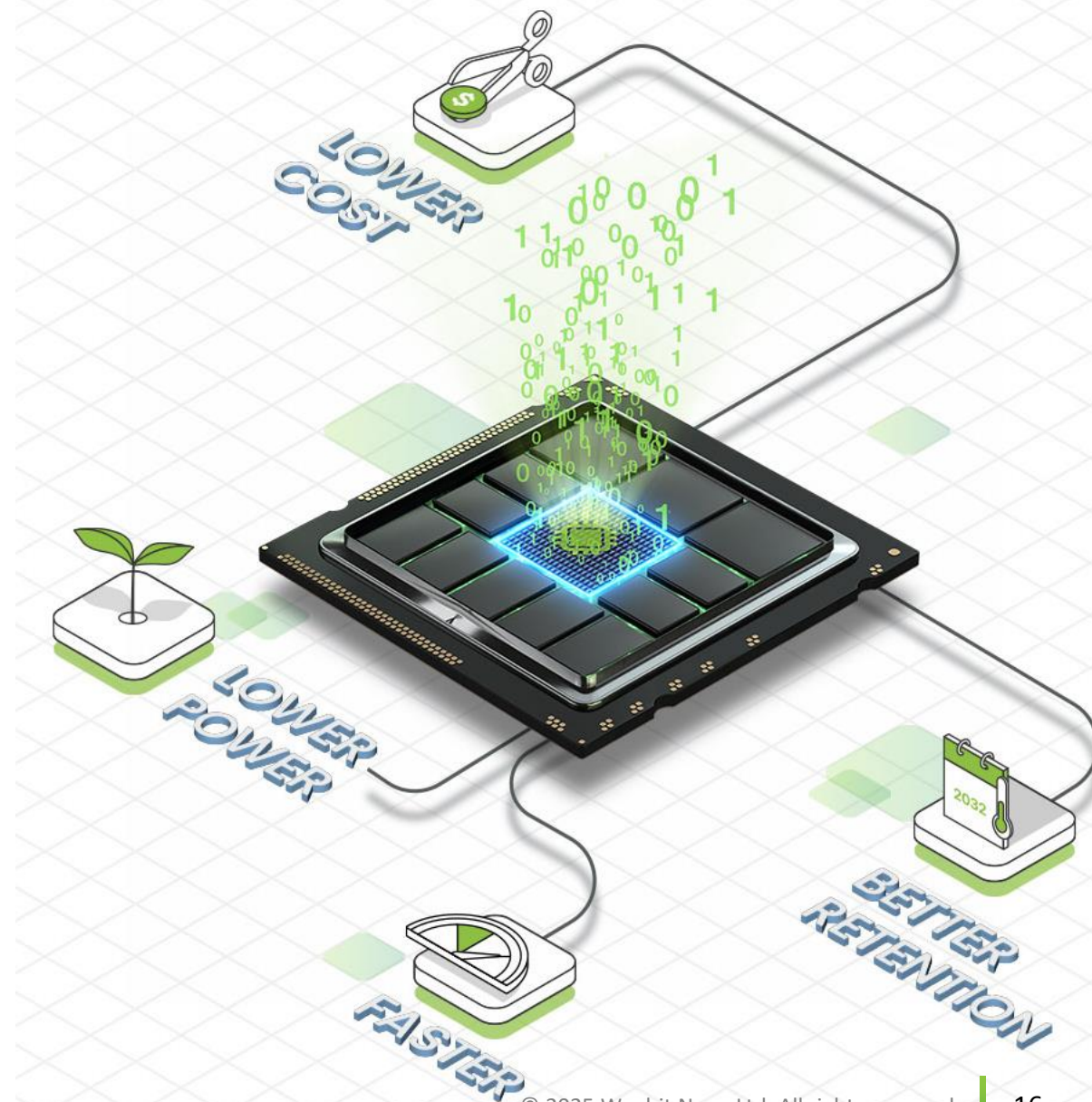
- ❖ OFF-chip:
 - ◆ MAML model trained on server (over than 50k iterations on GPU)
 - ◆ Output off-chip:
 - Optimized net parameters
- ❖ ON-chip:
 - ◆ Standalone ReRAM device able to quickly learn new tasks
 - ◆ Confidentiality assured between customers and between customer and company

Demonstration of few shot learning on ReRAM crossbar arrays



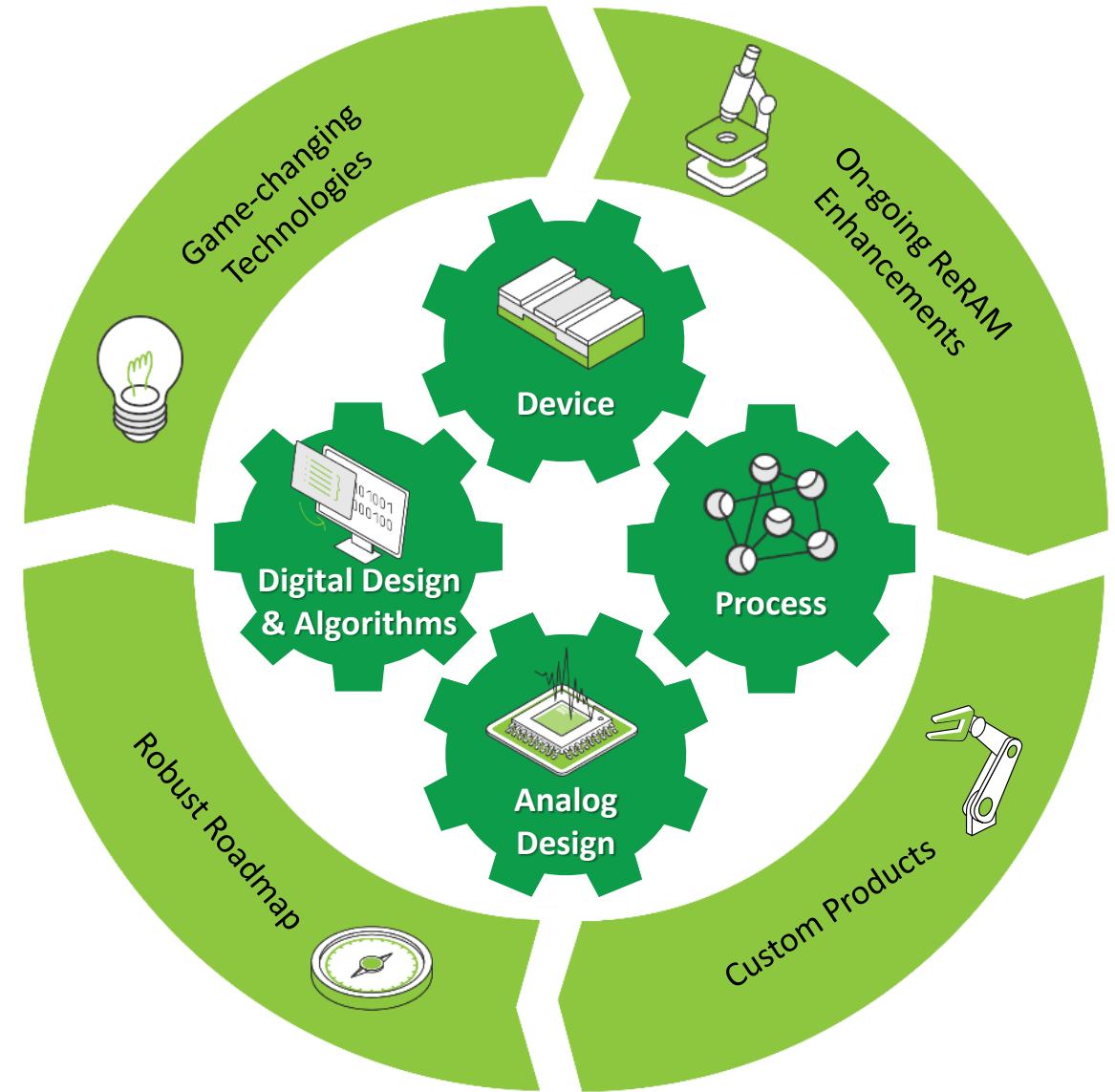
Outline

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Conclusions

- ❖ ReRAM has progressed from an emerging device to a **market ready technology**, replacing embedded flash for advanced nodes
- ❖ ReRAM characteristics are perfectly suited to MCU, consumer to automotive, thanks to high speed, cost efficiency, small footprint, scalability...
- ❖ Weebit ReRAM technology is already qualified for automotive, adopted in multiple fabs and IDMs
- ❖ ReRAM will enter the **AI roadmap** step-by-step (1) as embedded memory, (2) as computing device in IMC circuits, (3) as the core device for new concepts
- ❖ ReRAM requires **continuous technology development**, involving material, process, device, test, reliability and design experts



Thank You!

www.weebit-nano.com



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THE NEXT NVM IS HERE